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JUNE EDITORIAL HIGHLIGHTS

SPECIAL REPORT: OSCILLOSCOPES

It is important to understand the limitations that result from an MSO's analog and digital acquisition interaction.

MODULAR DAQ: Customer requests drive data-acquisition architecture innovation.

DESIGN FOR TEST: Cell-aware testing reduces semiconductor defect rates.

PXI FOR RF: Modular instruments boost automated wireless test.

UPGRADING LEGACY SYSTEMS: Proliferation of high-speed serial buses prompt legacy MIL/Aero system upgrades.

MEDICAL TEST: Standardizing RFID interference testing for medical devices further ensures patient safety.

50 YEARS OF TEST TECHNOLOGY: SPECTRUM ANALYZERS

The number of articles on spectrum analyzers as well as vector signal analyzers has increased along with coverage of wireless communications.

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